

STGW50HF60SD

60 A, 600 V, very low drop IGBT with soft and fast recovery diode

Features

- Very low on-state voltage drop
- Low switching off
- High current capability
- Very soft ultra fast recovery antiparallel diode

Application

- PV inverter
- UPS

Description

STGW50HF60SD is a very low drop IGBT based on new advanced planar technology, showing extremely low on-state voltage and limited turn-off losses. The overall performance makes this IGBT ideal in low frequency switches of mixed frequency topologies for PF \leq 1.

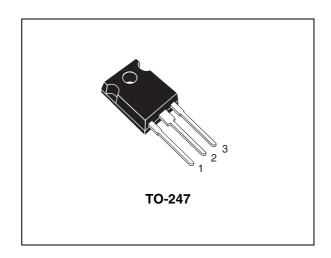


Figure 1. Internal schematic diagram

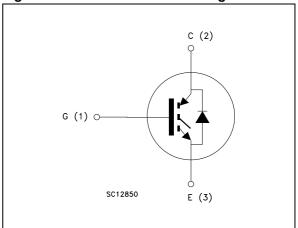


Table 1. Device summary

Order code	Marking	Package	Packaging
STGW50HF60SD	GW50HF60SD	TO-247	Tube

Electrical ratings STGW50HF60SD

1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{CES}	Collector-emitter voltage (V _{GE} = 0)	600	V
I _C ⁽¹⁾	Continuous collector current at T _C = 25 °C	110	Α
I _C ⁽¹⁾	Continuous collector current at T _C = 100 °C	60	Α
I _{CL} (2)	Turn-off latching current	60	Α
I _{CP} (3)	Pulsed collector current	130	Α
V _{GE}	Gate-emitter voltage	±20	V
P _{TOT}	Total dissipation at T _C = 25 °C	284	W
I _F	Diode RMS forward current at T _C = 25 °C	30	Α
I _{FSM}	Surge non repetitive forward current $t_p = 10 \text{ ms}$ sinusoidal	120	Α
T _j	Operating junction temperature	- 55 to 150	°C

^{1.} Calculated according to the iterative formula:

$$I_{C}(T_{C}) = \frac{T_{j(max)} - T_{C}}{R_{thj-c} \times V_{CE(sat)(max)}(T_{j(max)}, I_{C}(T_{C}))}$$

- 2. Vclamp = 80% of V_{CES}, T_j =150 °C, R_G=10 Ω , V_{GE}=15 V
- 3. Pulse width limited by maximum junction temperature and turn-off within RBSOA

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case IGBT	0.44	°C/W
R _{thj-case}	Thermal resistance junction-case diode	1.25	°C/W
R _{thj-amb}	Thermal resistance junction-ambient	50	°C/W

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(T_J=25°C unless otherwise specified)

Table 4. Static

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)CES}	Collector-emitter breakdown voltage (V _{GE} = 0)	I _C = 1 mA	600			V
V _{CE(sat)}	Collector-emitter saturation voltage	V_{GE} = 15 V, I_{C} = 30 A V_{GE} = 15 V, I_{C} = 30 A, T_{J} =125 °C		1.15	1.45	V V
V _{GE(th)}	Gate threshold voltage	$V_{CE} = V_{GE}, I_{C} = 250 \mu A$	3.5		5.7	V
I _{CES}	Collector cut-off current (V _{GE} = 0)	V _{CE} =600 V V _{CE} =600 V, T _J =125 °C			50 500	μ Α μ Α
I _{GES}	Gate-emitter leakage current (V _{CE} = 0)	V _{GE} =± 20 V			± 100	nA
9 _{fs}	Forward transconductance	V _{CE} = 15 V _, I _C = 30 A		25		S

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$egin{array}{c} C_{ m ies} \ C_{ m res} \end{array}$	Input capacitance Output capacitance Reverse transfer capacitance	V _{CE} = 25 V, f = 1 MHz, V _{GE} =0	-	4300 400 100	-	pF pF pF
Q _g Q _{ge} Q _{gc}	Total gate charge Gate-emitter charge Gate-collector charge	V _{CE} = 480 V, I _C = 30 A,V _{GE} =15 V	-	200 27 90	-	nC nC nC

Electrical characteristics STGW50HF60SD

Table 6. Switching on/off (inductive load)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r (di/dt) _{on}	Turn-on delay time Current rise time Turn-on current slope	V_{CC} = 400 V, I_{C} = 30 A R_{G} = 10 Ω V_{GE} = 15 V, (see Figure 15)	-	50 20 1280	-	ns ns A/µs
t _{d(on)} t _r (di/dt) _{on}	Turn-on delay time Current rise time Turn-on current slope	$V_{CC} = 400 \text{ V}, I_{C} = 30 \text{ A}$ $R_{G} = 10 \Omega V_{GE} = 15 \text{ V},$ $T_{J} = 125 \text{ °C} \text{ (see Figure 15)}$	-	47 22 1100	-	ns ns A/µs
$\begin{array}{c} t_{r}(V_{off}) \\ t_{d}(_{off}) \\ t_{f} \end{array}$	Off voltage rise time Turn-off delay time Current fall time	V_{CC} = 400 V, I_{C} = 30 A R_{G} = 10 Ω V_{GE} = 15 V, (see Figure 15)	-	370 220 465	-	ns ns ns
t _r (V _{off}) t _d (_{off}) t _f	Off voltage rise time Turn-off delay time Current fall time	$V_{CC} = 400 \text{ V}, I_{C} = 30 \text{ A}$ $R_{G} = 10 \Omega V_{GE} = 15 \text{ V},$ $T_{J} = 125 \text{ °C} \text{ (see Figure 15)}$	-	700 250 800	-	ns ns ns

Table 7. Switching energy (inductive load)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Eon ⁽¹⁾	Turn-on switching losses	$V_{CC} = 400 \text{ V}, I_{C} = 30 \text{ A}$		0.25		mJ
E _{off} (2)	Turn-off switching losses	R_{G} = 10 Ω , V_{GE} = 15 V,	-	4.2	-	mJ
E _{ts}	Total switching losses	(see Figure 15)		4.45		mJ
Eon (1)	Turn-on switching losses	$V_{CC} = 400 \text{ V}, I_{C} = 30 \text{ A}$		0.45		mJ
E _{off} (2)	Turn-off switching losses	R_{G} = 10 Ω , V_{GE} = 15 V,	-	7.8	-	mJ
E _{ts}	Total switching losses	T _J = 125 °C <i>(see Figure 15)</i>		8.25		mJ

Eon is the turn-on losses when a typical diode is used in the test circuit in Figure 15. If the IGBT is offered
in a package with a co-pack diode, the co-pack diode is used as external diode. IGBTs and diode are at
the same temperature (25°C and 125°C).

Table 8. Collector-emitter diode

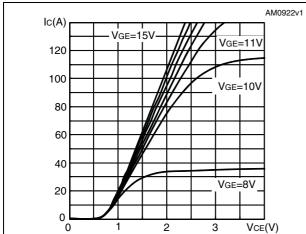
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _F	Forward on-voltage	I _F = 30 A I _F = 30 A, T _J = 125 °C	-	2.8 1.8	-	V V
t _{rr} Q _{rr} I _{rrm}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_F = 30 \text{ A}, V_R = 50 \text{ V},$ $di/dt = 100 \text{ A/}\mu\text{s}$ (see Figure 18)	-	67 140 4	-	ns nC A
t _{rr} Q _{rr} I _{rrm}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_F = 30 \text{ A}, V_R = 50 \text{ V},$ $T_J = 125 ^{\circ}\text{C},$ $di/dt = 100 \text{ A/}\mu\text{s}$ (see Figure 18)	-	103 390 7	-	ns nC A

^{2.} Turn-off losses include also the tail of the collector current.

2.1 Electrical characteristics (curves)

Figure 2. Output characteristics

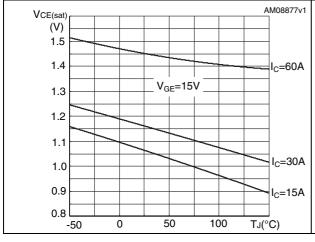
Figure 3. Transfer characteristics



120 100 80 60 40 20 0 2 4 6 8 10 VGE(V)

Figure 4. Collector-emitter on voltage vs temperature

Figure 5. Collector-emitter on voltage vs collector current



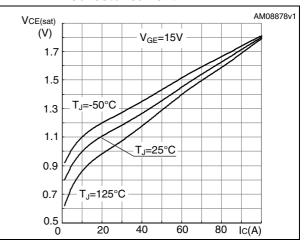
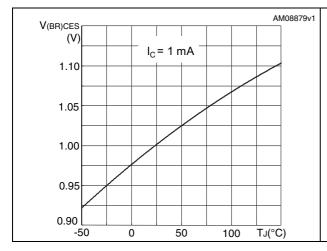
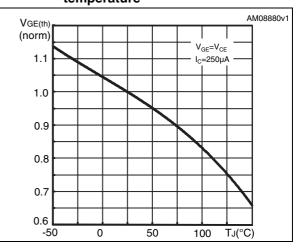


Figure 6. Breakdown voltage vs temperature Figure 7. Gate threshold voltage vs temperature





Electrical characteristics STGW50HF60SD

Figure 8. Gate charge vs gate-emitter voltage Figure 9. Capacitance variations

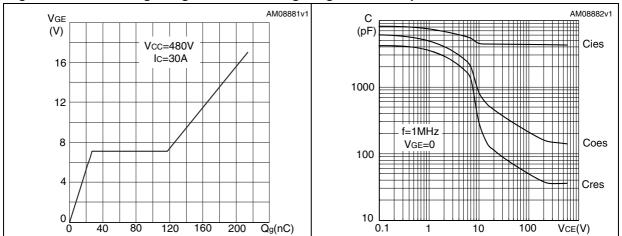


Figure 10. Switching losses vs collector current

Figure 11. Switching losses vs gate resistance

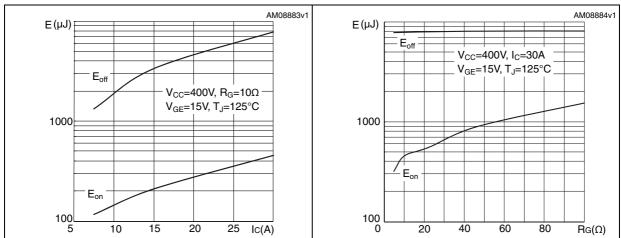


Figure 12. Switching losses vs temperature Figure 13. Turn-off SOA

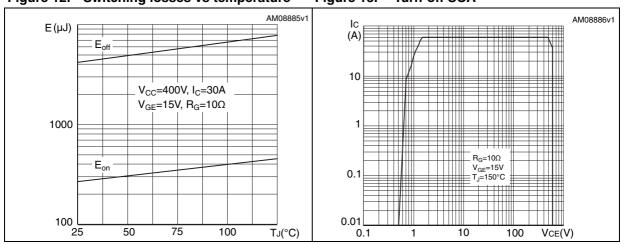
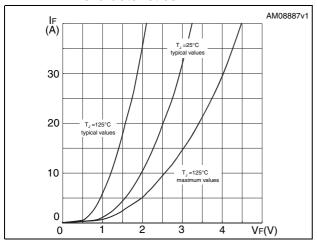


Figure 14. Emitter-collector diode characteristics



Test circuits STGW50HF60SD

3 Test circuits

Figure 15. Test circuit for inductive load switching

Figure 16. Gate charge test circuit

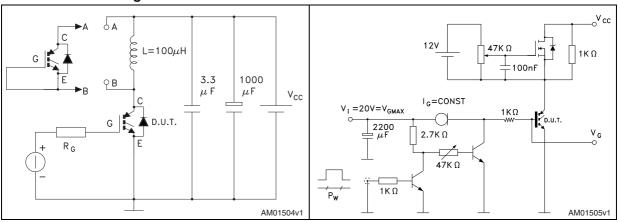
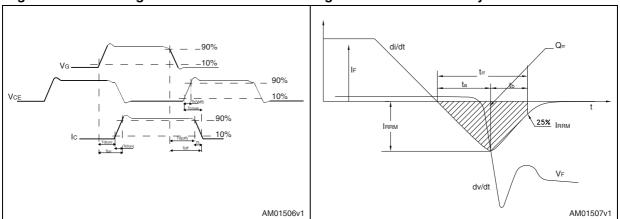


Figure 17. Switching waveform

Figure 18. Diode recovery time waveform



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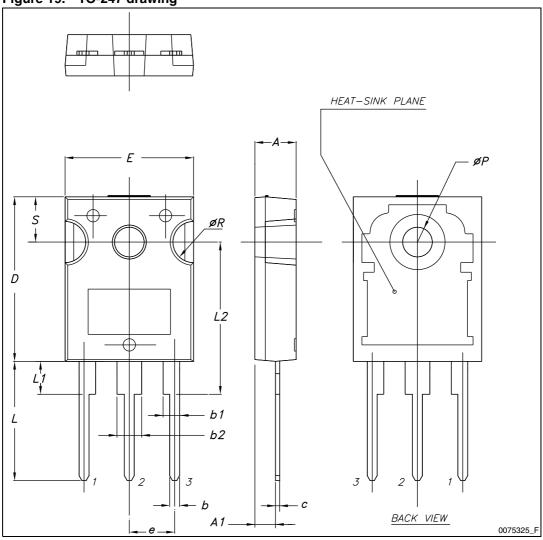
4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

Table 9. TO-247 mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
Α	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
С	0.40		0.80
D	19.85		20.15
E	15.45		15.75
е		5.45	
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S		5.50	

Figure 19. TO-247 drawing



Revision history STGW50HF60SD

5 Revision history

Table 10. Document revision history

Date	Revision	Changes
15-Jan-2010	1	Initial release.
21-Dec-2010	2	Document status promoted to datasheet.

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